

C0603C102J1HACTU

Aliases (C0603C102J1HAC7867) SMD Comm X8R HT150C, Ceramic, 1,000 pF, 5%, 100 VDC, X8R, SMD, MLCC, High Temperature, Ultra-Stable, 0603, 0.5 mm



Click here for the 3D model.

	General Information			
	Series	SMD Comm X8R HT150C		
	Style	SMD Chip		
	Description	SMD, MLCC, High Temperature, Ultra-Stable		
	Features	High Temperature, Ultra-Stable		
	RoHS	Yes		
	Termination	Tin		
	Marking	No		
	AEC-Q200	No		
	Typical Component Weight	4.8 mg		
	Shelf Life	78 Weeks		
	MSL	1		

	Specifications	
0603	Capacitance	1,000 pF
1.6mm +/-0.15mm	Measurement Condition	1 MHz 1.0Vrms
0.8mm +/-0.15mm	Tolerance	5%
0.8mm +/-0.07mm	Voltage DC	100 VDC
0.5mm MIN	Dielectric Withstanding Voltage	250 VDC
0.35mm +/-0.15mm	Temperature Range	-55/+150°C
	Temp. Coefficient	X8R
T&R, 180mm, Paper Tape	Capacitance Change with Reference to +25°C and 0 VDC Applied (TCC)	15%, 1MegaHz 1.0Vrms
4000	Dissipation Factor	2.5%1MHz1.0Vrms
	Aging Rate	0% Loss/Decade Hour: Refere Time is 1000 Hours

100 GOhms

Insulation Resistance

Statements of suitability for certain applications are based on our knowledge of typical operating conditions for such applications, but are not intended to constitute - and we specifically disclaim - any warranty concerning suitability for a specific customer application or use. This Information is intended for use only by customers who have the requisite experience and capability to determine the correct products for their application. Any technical advice inferred from this Information or otherwise provided by us with reference to the use of our products is given gratis, and we assume no obligation or liability for the advice given or results obtained.

Dimensions

Packaging Specifications

Packaging Quantity

Chip Size

L

W Т

S

В

Packaging

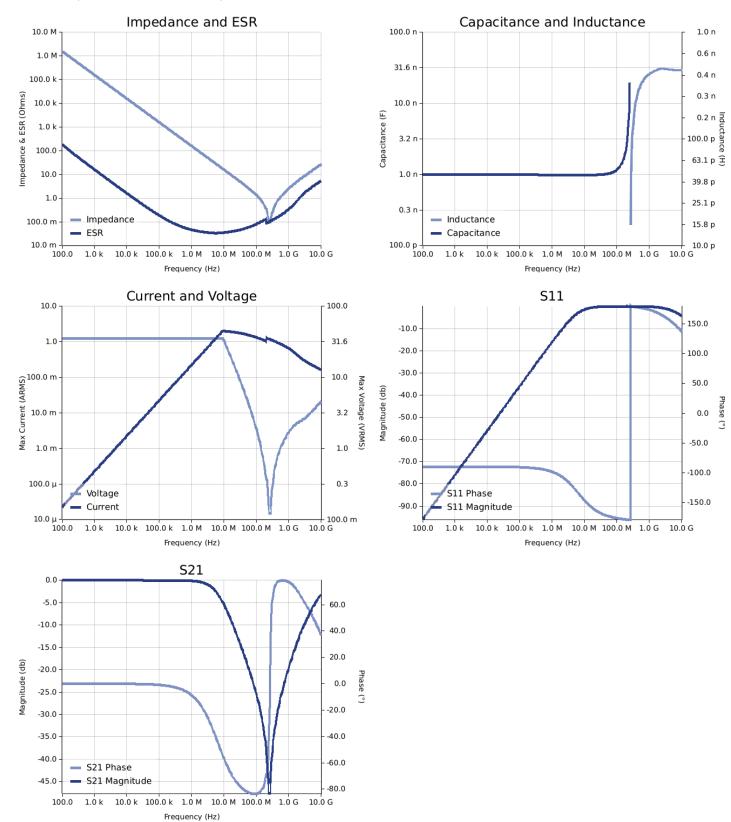
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Simulations

For the complete simulation environment please visit Y-SIM.





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These are simulations.

This is not a specification!

The responses shown represent the typical response for each part type. Specific responses may vary, depending on manufacturing variation affects of all parameters involved, including the specified tolerances applied to capacitance and unspecified variations of ESR, ESL, and leakage resistance.

The responses shown do not represent a specified or implied maximum capability of the device for all applications.

- The ESR used for ripple "Ripple Current/Voltage vs. Frequency" plots is the ESR at ambient temperature.

- The ESR is the "Temperature Rise vs. Ripple Current," voltage vs. Frequency plots is the ESR at ambient temperature. The ESR in the "Temperature Rise vs. Ripple Current," plots is adjusted to each incremental temperature rise before the power and ripple current is calculated. The effects shown herein are based on measured data from a multiple part sample of the parts in question. Ripple capability of this device will be factored by thermal resistance (Rth) created by circuit traces (addi affects of all parameters involved, including the specified tolerances applied to capacitance and unspecified variations of ESR, ESL, and leakage resistance. The peak voltages generated in the "Temperature Rise vs. Combined Ripple Currents" plot are calculated for each frequency and are not combined with voltages
- generated at any other harmonics. Please consult with the catalog or field applications engineer for maximum capability of the device in specific applications.

All product information and data (collectively, the "Information") are subject to change without notice.

KEMET K-SIM is designed to simulate behavior of components with respect to frequency, ambient temperature, and DC bias levels. The responses shown represent the typical response for each part type. Specific responses may vary, depending on manufacturing variation effects of all parameters involved, including the specified tolerances applied to capacitance and unspecified variations of ESR, ESL, and leakage resistance.

All Information given herein is believed to be accurate and reliable, but is presented without guarantee, warranty, or responsibility of any kind, expressed or implied. Statements of suitability for certain applications are based on our knowledge of typical operating conditions for such applications, but are not intended to constitute – and we specifically disclaim – any warranty concerning suitability for a specific customer application or use. This Information is intended for use only by customers who have the requisite experience and capability to determine the correct products for their application. Any technical advice inferred from this Information or otherwise provided by us with reference to the use of our products is given gratis, and we assume no obligation or liability for the advice given or results obtained.

If you have any questions please contact K-SIM.